STF18N60M2



N-channel 600 V, 0.255 Ω typ., 13 A MDmesh II Plus™ low Q_g Power MOSFET in a TO-220FP package

Datasheet - production data

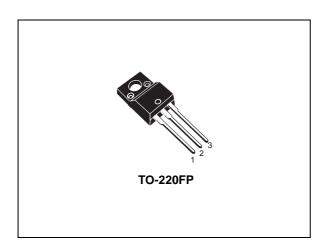
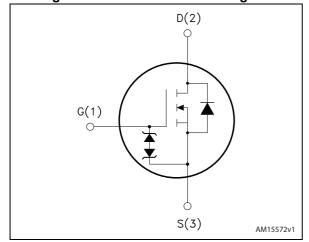


Figure 1. Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STF18N60M2	650 V	0.28 Ω	13 A

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

- Switching applications
- · LLC converters, resonant converters

Description

This device is an N-channel Power MOSFET developed using a new generation of MDmesh $^{\text{TM}}$ technology: MDmesh II Plus $^{\text{TM}}$ low Q_g . This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order code	Marking	Package	Packaging
STF18N60M2	18N60M2	TO-220FP	Tube

Contents STF18N60M2

Contents

1	Electrical ratings 3
2	Electrical characteristics4
	2.1 Electrical characteristics (curves) 6
3	Test circuits 8
4	Package mechanical data
5	Revision history12

STF18N60M2 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	± 25	V
I _D	Drain current (continuous) at T _C = 25 °C	13 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	8 ⁽¹⁾	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	52 ⁽¹⁾	Α
P _{TOT}	Total dissipation at T _C = 25 °C	25	W
dv/dt (3)	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50	
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s,T _C = 25 °C)	2500	V
T _{stg}	Storage temperature		°C
T _j	Max. operating junction temperature	- 55 to 150	

- 1. Limited by package
- 2. Pulse width limited by safe operating area
- 3. $I_{SD} \leq$ 13 A, di/dt \leq 400 A/ μ s; $V_{DS\ peak}$ < $V_{(BR)DSS}$, V_{DD} =400 V.
- $4. \quad V_{DS} \leq 480 \ V$

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	3.6	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T_{jmax})	3	Α
E _{AS}	Single pulse avalanche energy (starting T_j =25°C, I_D = I_{AR} ; V_{DD} =50)	135	mJ

Electrical characteristics STF18N60M2

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			٧
1	Zero gate voltage	V _{DS} = 600 V			1	μΑ
I _{DSS}	drain current (V _{GS} = 0)	V _{DS} = 600 V, T _C =125 °C			100	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 6.5 A		0.255	0.28	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	791	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	1	40	ı	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	5.6	-	pF
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	-	164.5	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D = 0	-	5.6	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 13 A,	-	21.5	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	3.2	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15)	-	11.3	-	nC

^{1.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	12	-	ns
t _r	Rise time	$V_{DD} = 300 \text{ V}, I_{D} = 6.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 14</i> and <i>Figure 19</i>)	-	9	-	ns
t _{d(off)}	Turn-off delay time		-	47	-	ns
t _f	Fall time		-	10.6	-	ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		13	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		52	Α
V _{SD} (2)	Forward on voltage $I_{SD} = 13 \text{ A}, V_{GS} = 0$		-		1.6	V
t _{rr}	Reverse recovery time	10.4 11/1/ 100.4/	-	305		ns
Q _{rr}	Reverse recovery charge	I _{SD} = 13 A, di/dt = 100 A/μs V _{DD} = 60 V (see <i>Figure 16</i>)	-	3.3		nC
I _{RRM}	Reverse recovery current	1 VDD = 00 V (000 / 1ga/0 /0)	-	22		Α
t _{rr}	Reverse recovery time	I _{SD} = 13 A, di/dt = 100 A/μs	-	417		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 ^{\circ}\text{C}$		4.6		nC
I _{RRM}	Reverse recovery current	(see Figure 16)		22		Α

^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STF18N60M2

Electrical characteristics (curves) 2.1

Figure 2. Safe operating area

AM15834v1 (A) 10 10μs 100µs 1ms 10ms Tj=150°C 0.1 Tc=25°C Single pulse 100 V_{DS}(V) 0.1

Figure 3. Thermal impedance

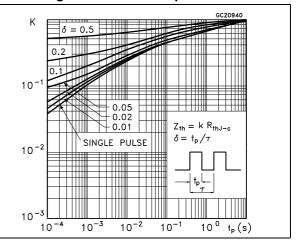


Figure 4. Output characteristics

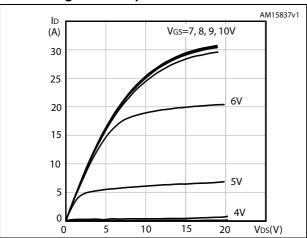


Figure 5. Transfer characteristics

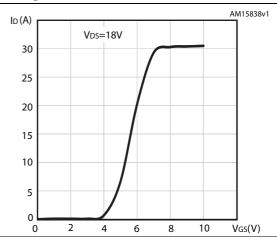


Figure 6. Gate charge vs gate-source voltage

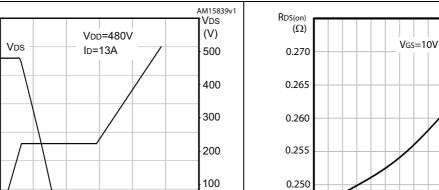


Figure 7. Static drain-source on-resistance

8

10

12

6

ID(A)

(V)

12

10

8

6

2

5

10

15

20

25 Qg(nC)

0.245

2

4

Figure 8. Capacitance variations

Figure 9. Normalized gate threshold voltage vs. temperature

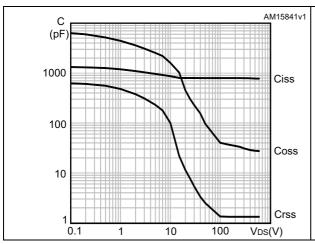
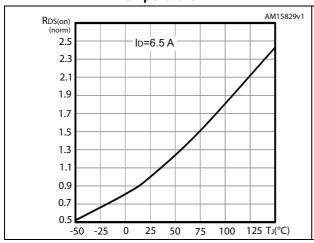


Figure 10. Normalized on-resistance vs temperature

Figure 11. Source-drain diode forward characteristics



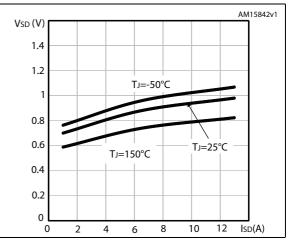
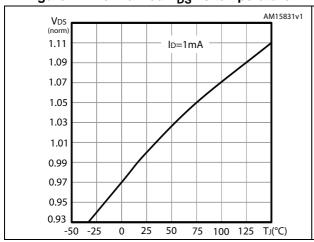
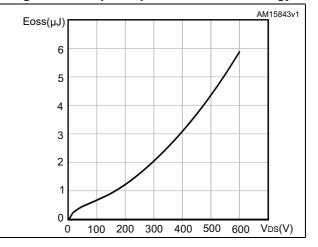


Figure 12. Normalized V_{DS} vs temperature

Figure 13. Output capacitance stored energy





Test circuits STF18N60M2

3 Test circuits

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

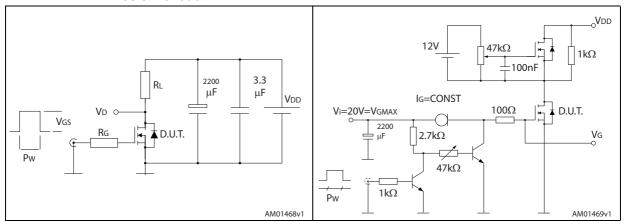


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

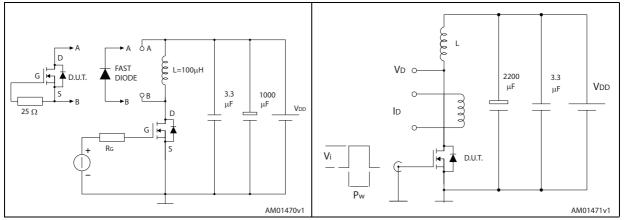
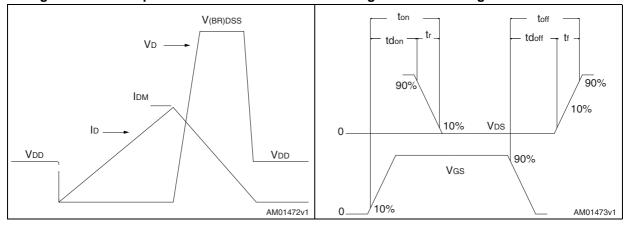


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.



Table 9. TO-220FP mechanical data

		mm	
Dim.	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
Е	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

-*B*-Dia L6 L2 *L7* L3 F1 **L4** F2 Ε -G1-7012510_Rev_K_B

Figure 20. TO-220FP drawing

Revision history STF18N60M2

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
04-Jun-2013	1	First release.
05-Jun-2013	2	 Added: note 2 in Table 2 Modified: typical value for C_{iss}, C_{oss eq}., Q_g, Q_{gs}, Q_{gd} Modified: Figure 10 and 11 Minor text changes

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